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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/737,336	12/16/2003	Kenichiro Kobayashi	KIK01 P-322A	6152
277	7590	09/29/2004	EXAMINER	
PRICE HENEVELD COOPER DEWITT & LITTON, LLP			SUN, XIUQIN	
695 KENMOOR, S.E.			ART UNIT	
P O BOX 2567			PAPER NUMBER	
GRAND RAPIDS, MI 49501			2863	

DATE MAILED: 09/29/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

10/737,336

Applicant(s)

KOBAYASHI ET AL.

Examiner

Xiuqin Sun

Art Unit

2863

Am

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 16 December 2003.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-13 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-13 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 16 December 2003 is/are: a) ☒ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☒ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date 04/05/04&12/16/04.
- 4) ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date. _____.
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____.

DETAILED ACTION

Claim Rejections - 35 USC § 103

1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

2. Claims 1, 2, 3, 4, 7-11 and 13 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hiyoshi (JP07110216, English translation) in view of Miyagawa (U.S. Pat. No. 3739697).

Hiyoshi teaches a method and apparatus for direct image pick-up of a particular granular speck pattern generated by reflecting light of a laser beam depending on a degree of roughness of the surface of an object to be inspected (see Abstract, Fig. 1; sections 0002, 0006 and 0007), comprising: irradiating said object to be inspected with the laser beam (sections 0009 and 0012); directly picking up said granular speck pattern in a relatively well lighted environment using a lensless video camera having a CCD (Charge Coupled Device) element incorporated in said video camera (Fig. 1; sections 0006, 0007, 0012, 0015, 0016 and 0018).

Hiyoshi further teaches a method and apparatus for direct image pick-up of a particular granular speck pattern generated by the transmitted light of a laser beam diffusively reflecting depending on a degree of roughness of the laser beam irradiated

onto the surface of an object to be inspected or shapes of fine ingredients constituting said object to be inspected (see Abstract, Fig. 1; sections 0002, 0006 and 0007), comprising the steps of: irradiating said object to be inspected with the laser beam (sections 0009 and 0012); directly picking up said granular speck pattern in a relatively well lighted environment using a lensless video camera having a CCD element incorporated in said video camera (Fig. 1; sections 0006, 0007, 0012, 0015, 0016 and 0018).

The teaching of Hiyoshi further includes: measuring an amount which the object has moved (sections 0012 and 0022); calculating the amount of movement on the basis of movement of the granular speck pattern with respect to an index of the granular speck pattern (sections 0018 and 0031); and displaying a result of the calculation as a numerical value of the measured amount of movement (sections 0012 and 0022); an A/D converter coupled to said camera to convert an analog signal supplied from said camera to a digital signal (sections 0013, 0016 and 0018); a processing unit coupled to the A/D converter to calculate the amount of movement of said object on the basis of movement of the granular speck in said pattern with respect to a pixel interval of said granular speck pattern picked up by said camera and represented by said A/D converted signal (sections 0007, 0016, 0018 and 0022); and a display coupled to said processing unit to display the amount of movement calculated by said processing unit (Fig. 1; sections 0018 and 0023); and an electrical circuit coupled to said camera for calculating the amount of movement of said object on the basis of movement of the granular speck in said pattern with respect to a pixel interval of said granular speck

pattern picked up by said camera and displaying the amount of movement calculated by said electrical circuit (Fig. 1; sections 0007, 0016, 0018 and 0022 and 0023).

Hiyoshi does not mention that: providing a shielding tube coupled to said camera to shield extraneous light rays.

Miyagawa discloses a data recording device for use with cameras, comprising a shielding tube coupled to said camera to shield extraneous light rays (col. 3, lines 14-37 and col. 4, lines 4-14).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Miyagawa in the Hiyoshi system in order to prevent extraneous light from entering into the light shielding tube so that no noise light would interfere the signal light in detecting the target (Miyagawa, col. 3, lines 14-37 and col. 4, lines 4-14).

3. Claims 5, 6 and 12 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hiyoshi in view of Miyagawa.

Hiyoshi further teaches a method and apparatus for direct image pick-up of a particular granular speck pattern generated by the transmitted light of a laser beam diffusively reflecting depending on a degree of roughness of the laser beam irradiated onto the surface of an object to be inspected or shapes of fine ingredients constituting said object to be inspected (see Abstract, Fig. 1; sections 0002, 0006 and 0007), comprising the steps of: irradiating said object to be inspected with the laser beam (sections 0009 and 0012); directly picking up said granular speck pattern in a relatively well lighted environment using a lensless video camera having a CCD element

incorporated in said video camera (Fig. 1; sections 0006, 0007, 0012, 0015, 0016 and 0018).

Hiyoshi does not mention that: said camera is a digital camera; providing a shielding tube coupled to said camera to shield extraneous light rays.

It is well known that a digital camera is a specific type of camera. It would have been obvious to one having ordinary skill in the art at the time the invention was made to employ a digital camera in the invention of Hiyoshi so that said A/D converter could be omitted in converting an analog signal to a digital signal of the measurement.

Miyagawa discloses a data recording device for use with cameras, comprising a shielding tube coupled to said camera to shield extraneous light rays (col. 3, lines 14-37 and col. 4, lines 4-14).

It would have been obvious to one having ordinary skill in the art at the time the invention was made to include the teaching of Miyagawa in the Hiyoshi system in order to prevent extraneous light from entering into the light shielding tube so that no noise light would interfere the signal light in detecting the target (Miyagawa, col. 3, lines 14-37 and col. 4, lines 4-14).

Contact Information

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Xiuqin Sun whose telephone number is (571)272-2280. The examiner can normally be reached on 6:30am-4:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on (571)272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

XS

September 22, 2004

Xiuqin Sun
Examiner
Art Unit 2863

John Barlow
Supervisory Patent Examiner
Technology Center 2800